Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/665,574	TAKAOKI, KAZUO	
Examiner	Art Unit	
Rip A. Lee	1713	

	SEAR	RCHED	
Class	Subclass	Date	Examiner
502	155	11-25-1200	17
202	117		
.202	1233		
276	160		
576	Ð	4	
	_		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
_	.1				
ĺ					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
pater yearh	11-25-2X	51		
· · · · · · · · · · · · · · · · · · ·				